

Description

The VST20N680 uses **Super Trench** technology that is uniquely optimized to provide the most efficient high frequency switching performance. Both conduction and switching power losses are minimized due to an extremely low combination of $R_{\text{DS(ON)}}$ and Q_g . This device is ideal for high-frequency switching and synchronous rectification.

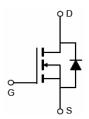
General Features

- V_{DS} =200V, I_D =20A $R_{DS(ON)}$ =68m Ω (typical) @ V_{GS} =10V
- Excellent gate charge x R_{DS(on)} product(FOM)
- Very low on-resistance R_{DS(on)}
- 175 °C operating temperature
- Pb-free lead plating

Application

- LED backlighting
- Ideal for high-frequency switching and synchronous rectification





Schematic Diagram

Package Marking and Ordering Information

| Device Marking | Device | Device Package | Reel Size | Tape width | Quantity |
|----------------|-----------|----------------|-----------|------------|----------|
| VST20N680-TC | VST20N680 | TO-220C | - | - | - |

Absolute Maximum Ratings (T_A=25 ℃unless otherwise noted)

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|--|------------------------|------------|------|--|
| Parameter | Symbol Limit | | Unit | |
| Drain-Source Voltage | V _{DS} | 200 | V | |
| Gate-Source Voltage | V _{GS} | ±20 | V | |
| Drain Current-Continuous | I _D | 20 | А | |
| Drain Current-Continuous(T _C =100 °C) | I _D (100°C) | 14 | А | |
| Pulsed Drain Current | I _{DM} | 80 | А | |
| Maximum Power Dissipation | P _D | 110 | W | |
| Derating factor | | 0.73 | W/°C | |
| Single pulse avalanche energy (Note 5) | E _{AS} | 180 | mJ | |
| Operating Junction and Storage Temperature Range | T_{J}, T_{STG} | -55 To 175 | ℃ | |

Thermal Characteristic

| Thermal Résistance, Junction-to-Case ^(Note 2) | R _{θJC} | 1.37 | °C/W |
|--|------------------|------|------|
|--|------------------|------|------|



Electrical Characteristics (T_A=25°C unless otherwise noted)

| Parameter | Symbol | Condition | Min | Тур | Max | Unit |
|------------------------------------|---------------------|---|-----|-----|------|------|
| Off Characteristics | | | • | • | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | BV _{DSS} V _{GS} =0V I _D =250µA | | - | - | V |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} =200V,V _{GS} =0V | - | - | 1 | μΑ |
| Gate-Body Leakage Current | I _{GSS} | V _{GS} =±20V,V _{DS} =0V | - | - | ±100 | nA |
| On Characteristics (Note 3) | | | • | | | • |
| Gate Threshold Voltage | $V_{GS(th)}$ | $V_{DS}=V_{GS}$, $I_{D}=250\mu A$ | 2.5 | 3.5 | 4.5 | V |
| Drain-Source On-State Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =20A | - | 68 | 78 | mΩ |
| Forward Transconductance | g Fs | V_{DS} =5 V , I_D =20 A | 20 | - | - | S |
| Dynamic Characteristics (Note4) | | | • | | | • |
| Input Capacitance | C _{lss} | 14 4001/11 01/ | - | 951 | | PF |
| Output Capacitance | C _{oss} | $V_{DS}=100V, V_{GS}=0V,$ | - | 82 | | PF |
| Reverse Transfer Capacitance | C _{rss} | F=1.0MHz | - | 2 | | PF |
| Switching Characteristics (Note 4) | | | • | | | • |
| Turn-on Delay Time | t _{d(on)} | | - | 6 | - | nS |
| Turn-on Rise Time | t _r | V_{DD} =100V, RL=8 Ω | - | 7 | - | nS |
| Turn-Off Delay Time | t _{d(off)} | V_{GS} =10 V , R_{G} =3 Ω | - | 15 | - | nS |
| Turn-Off Fall Time | t _f | | - | 4 | - | nS |
| Total Gate Charge | Qg | | - | 18 | - | nC |
| Gate-Source Charge | Q _{gs} | V _{DS} =100V,I _D =20A, | - | 7.5 | - | nC |
| Gate-Drain Charge | Q_{gd} | V _{GS} =10V | - | 4.6 | - | nC |
| Drain-Source Diode Characteristics | | | | | | • |
| Diode Forward Voltage (Note 3) | V _{SD} | V _{GS} =0V,I _S =20A | - | - | 1.2 | V |
| Diode Forward Current (Note 2) | Is | | - | - | 20 | Α |
| Reverse Recovery Time | t _{rr} | $T_J = 25^{\circ}C, I_F = I_S$ | - | 30 | - | nS |
| Reverse Recovery Charge | Qrr | $di/dt = 100A/\mu s^{(Note3)}$ | - | 125 | - | nC |

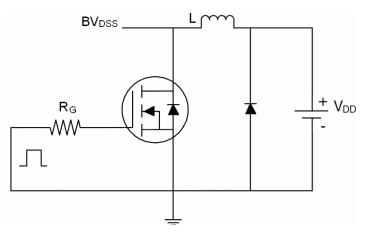
Notes:

- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 2. Surface Mounted on FR4 Board, $t \le 10$ sec.
- 3. Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 2%.
- 4. Guaranteed by design, not subject to production
- 5. EAS condition : Tj=25 $^{\circ}\!\!\mathrm{C}$,V_DD=50V,V_G=10V,L=0.5mH,Rg=25 Ω

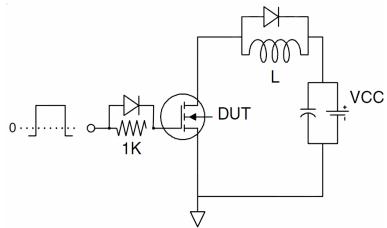


Test Circuit

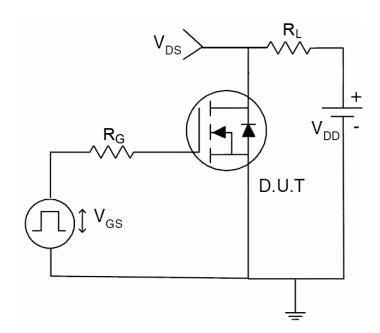
1) E_{AS} test Circuit



2) Gate charge test Circuit



3) Switch Time Test Circuit







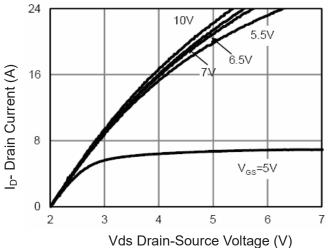


Figure 1 Output Characteristics

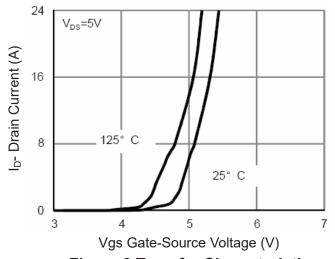


Figure 2 Transfer Characteristics

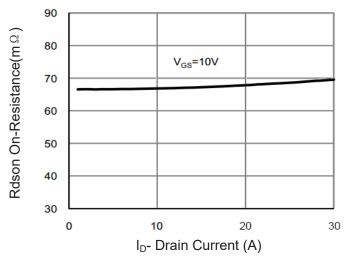


Figure 3 Rdson- Drain Current

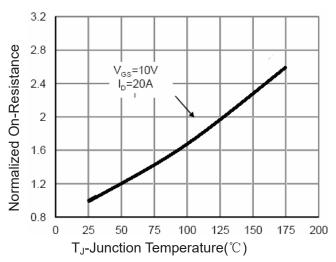


Figure 4 Rdson-Junction Temperature

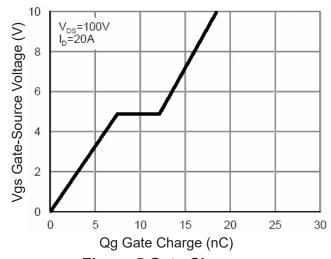


Figure 5 Gate Charge

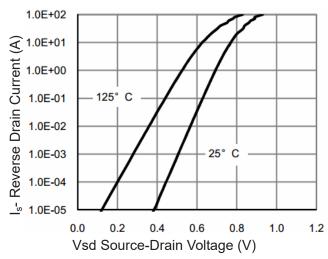
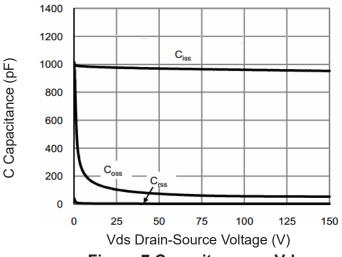


Figure 6 Source- Drain Diode Forward

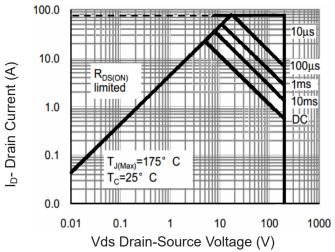




140 120 100 Power Dissipation (W) 80 60 40 20 0 0 75 100 125 150 175 T_J-Junction Temperature(°C)

Figure 7 Capacitance vs Vds

Figure 9 Power De-rating



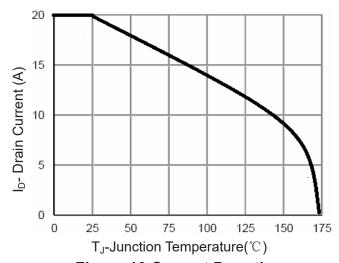
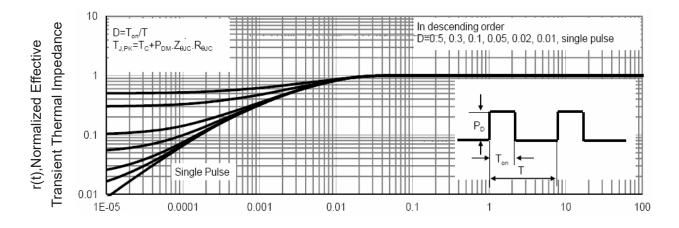


Figure 8 Safe Operation Area

Figure 10 Current De-rating



Square Wave Pluse Duration(sec)

Figure 11 Normalized Maximum Transient Thermal Impedance